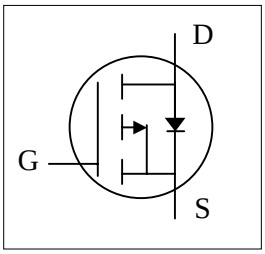
AP9435GG

Pb Free Plating Product

Advanced Power Electronics Corp.

P-CHANNEL ENHANCEMENT MODE POWER MOSFET

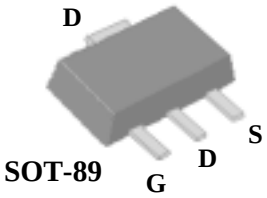
- ▼ **Low Gate Charge**
- ▼ **Fast Switching Characteristic**
- ▼ **Single Drive Requirement**
- ▼ **RoHS Compliant**



BV_{DSS}	-30V
$R_{DS(ON)}$	50mΩ
I_D	- 4.2A

Description

The Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, ultra low on-resistance and cost-effectiveness.



SOT-89

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	- 30	V
V_{GS}	Gate-Source Voltage	±20	V
I_D@T_A=25℃	Continuous Drain Current, V_{GS} @ 4.5V[3]	- 4.2	A
I_D@T_A=70℃	Continuous Drain Current, V_{GS} @ 4.5V[3]	-3.4	A
I_{DM}	Pulsed Drain Current[1]	-20	A
P_D@T_A=25℃	Total Power Dissipation	1.25	W
	Linear Derating Factor	0.01	W/℃
T_{STG}	Storage Temperature Range	-55 to 150	℃
T_J	Operating Junction Temperature Range	-55 to 150	℃

Thermal Data

Symbol	Parameter		Value	Unit
Rthj-a	Thermal Resistance Junction-ambient[3]	Max.	100	℃/W

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=-250uA	-30	-	-	V
$\Delta BV_{DSS}/\Delta T_j$	Breakdown Voltage Temperature Coefficient	Reference to 25℃, I_D=-1mA	-	-0.1	-	V/℃
$R_{DS(ON)}$	Static Drain-Source On-Resistance[2]	V_{GS}=-10V, I_D=-4A	-	-	50	mΩ
		V_{GS}=-4.5V, I_D=-2A	-	-	90	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=-250uA	-1	-	-3	V
g_{fs}	Forward Transconductance[2]	V_{DS}=-10V, I_D=-4A	-	6	-	S
I_{DSS}	Drain-Source Leakage Current (T_j=25°C)	V_{DS}=-30V, V_{GS}=0V	-	-	-1	uA
	Drain-Source Leakage Current (T_j=70°C)	V_{DS}=-24V, V_{GS}=0V	-	-	-25	uA
I_{GSS}	Gate-Source Leakage	V_{GS}=± 20V	-	-	±100	nA
Q_g	Total Gate Charge[2]	I_D=-4A	-	10	16	nC
Q_{gs}	Gate-Source Charge	V_{DS}=-25V	-	2	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	V_{GS}=-4.5V	-	6	-	nC
$t_{d(on)}$	Turn-on Delay Time[2]	V_{DS}=-15V	-	10	-	ns
t_r	Rise Time	I_D=-1A	-	7	-	ns
$t_{d(off)}$	Turn-off Delay Time	R_G=3.3Ω,V_{GS}=-10V	-	26	-	ns
t_f	Fall Time	R_D=15Ω	-	14	-	ns
C_{iss}	Input Capacitance	V_{GS}=0V	-	520	830	pF
C_{oss}	Output Capacitance	V_{DS}=-25V	-	180	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	130	-	pF
R_g	Gate Resistance	f=1.0MHz	-	16	24	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage[2]	I_S=-1A, V_{GS}=0V	-	-	-1.3	V
t_{rr}	Reverse Recovery Time	I_S=-4A, V_{GS}=0V,	-	30	-	ns
Q_{rr}	Reverse Recovery Charge	dI/dt=-100A/μs	-	24	-	nC

Notes:

1.Pulse width limited by safe operating area.

2.Pulse width ≤300us , duty cycle ≤2%.

3.Surface mount on FR4 board, t ≤ 10s.

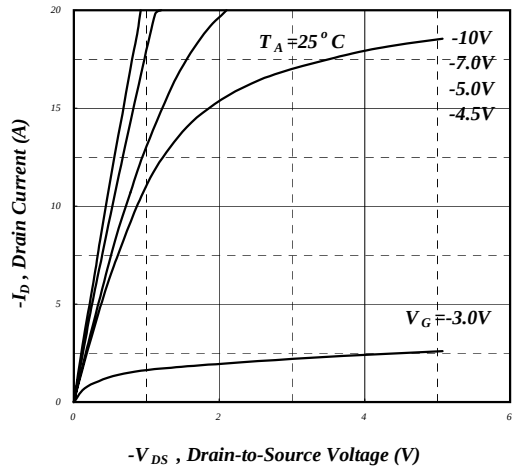


Fig 1. Typical Output Characteristics

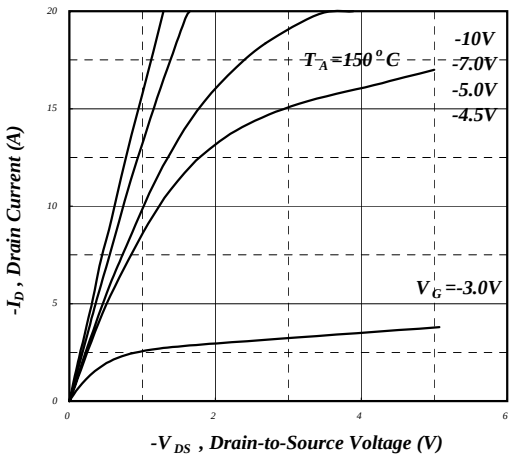


Fig 2. Typical Output Characteristics

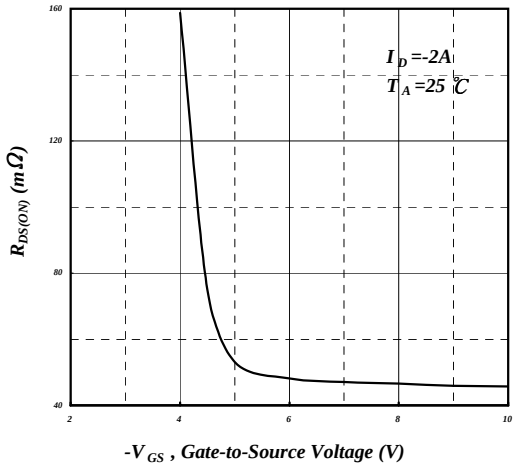


Fig 3. On-Resistance v.s. Gate Voltage

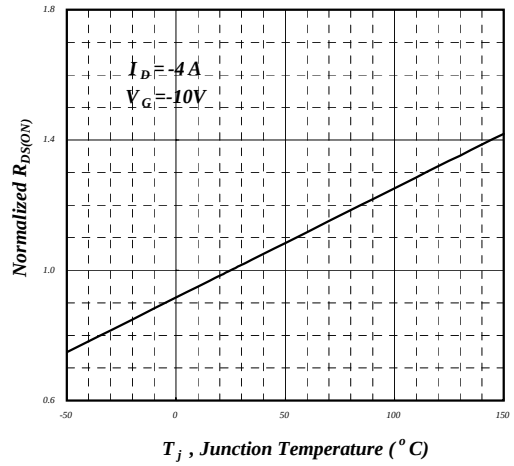


Fig 4. Normalized On-Resistance v.s. Junction Temperature

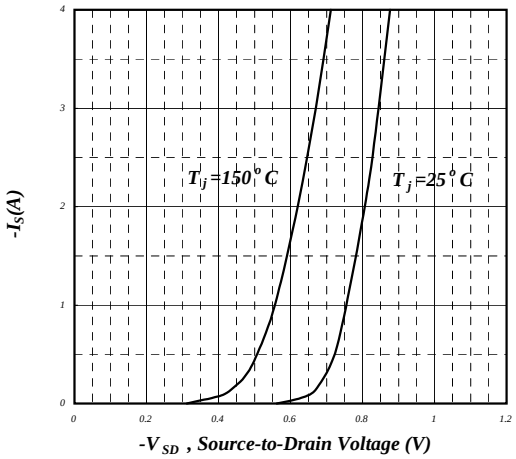


Fig5. Forward Characteristic of Reverse Diode

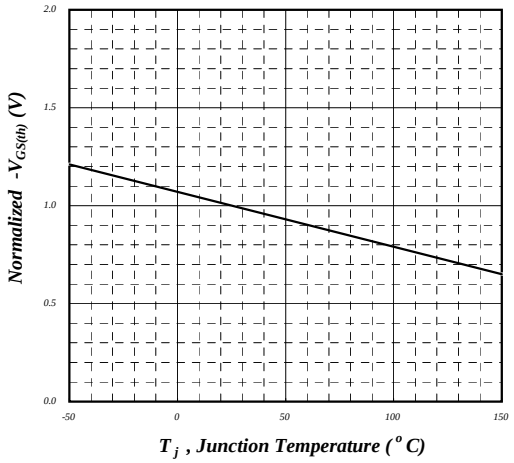


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

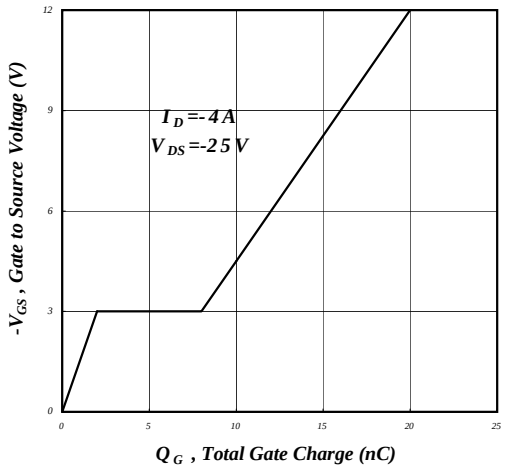


Fig 7. Gate Charge Characteristics

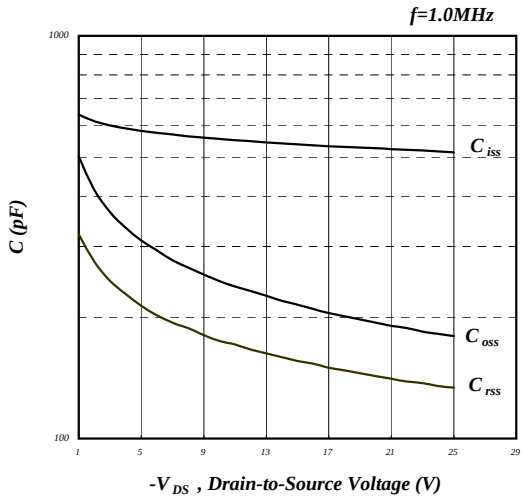


Fig 8. Typical Capacitance Characteristics

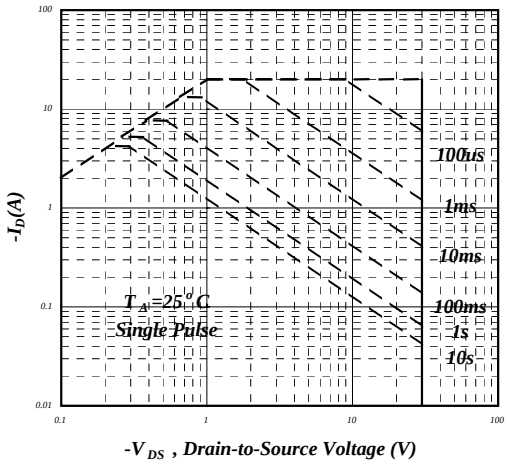


Fig 9. Maximum Safe Operating Area

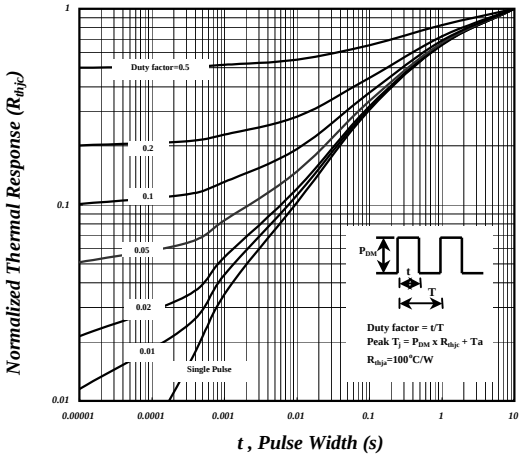


Fig 10. Effective Transient Thermal Impedance

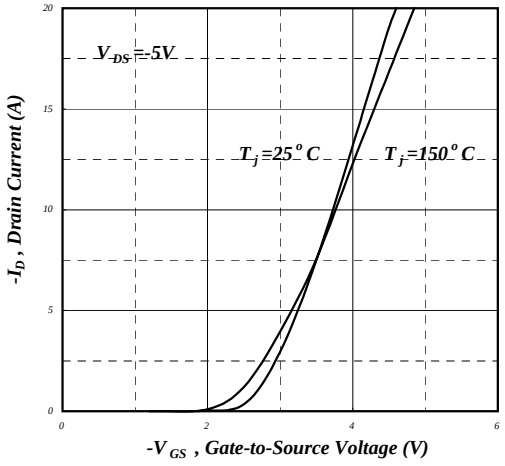


Fig 11. Transfer Characteristics

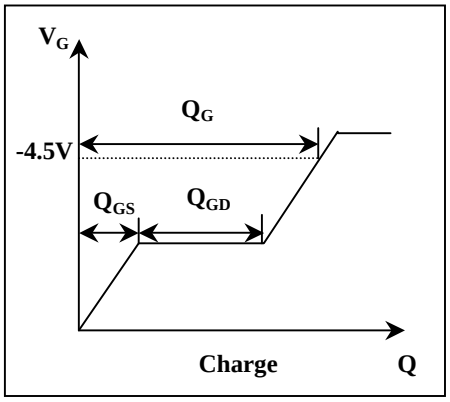


Fig 12. Gate Charge Waveform